

# FQB47P06 / FQI47P06

## 60V P-Channel MOSFET

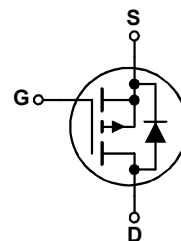
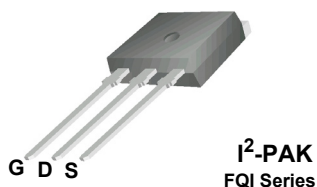
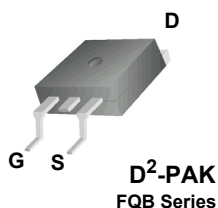
### General Description

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand a high energy pulse in the avalanche and commutation modes. These devices are well suited for low voltage applications such as automotive, DC/DC converters, and high efficiency switching for power management in portable and battery operated products.

### Features

- -47A, -60V,  $R_{DS(on)} = 0.026\Omega$  @  $V_{GS} = -10V$
- Low gate charge ( typical 84 nC)
- Low  $C_{rss}$  ( typical 320 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- 175°C maximum junction temperature rating



### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol         | Parameter                                                                     | FQB47P06 / FQI47P06 | Units               |
|----------------|-------------------------------------------------------------------------------|---------------------|---------------------|
| $V_{DSS}$      | Drain-Source Voltage                                                          | -60                 | V                   |
| $I_D$          | Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )                       | -47                 | A                   |
|                | - Continuous ( $T_C = 100^\circ\text{C}$ )                                    | -33.2               | A                   |
| $I_{DM}$       | Drain Current - Pulsed (Note 1)                                               | -188                | A                   |
| $V_{GSS}$      | Gate-Source Voltage                                                           | $\pm 25$            | V                   |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                                       | 820                 | mJ                  |
| $I_{AR}$       | Avalanche Current (Note 1)                                                    | -47                 | A                   |
| $E_{AR}$       | Repetitive Avalanche Energy (Note 1)                                          | 16                  | mJ                  |
| dv/dt          | Peak Diode Recovery dv/dt (Note 3)                                            | -7.0                | V/ns                |
| $P_D$          | Power Dissipation ( $T_A = 25^\circ\text{C}$ ) *                              | 3.75                | W                   |
|                | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                                | 160                 | W                   |
|                | - Derate above $25^\circ\text{C}$                                             | 1.06                | W/ $^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                       | -55 to +175         | $^\circ\text{C}$    |
| $T_L$          | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300                 | $^\circ\text{C}$    |

### Thermal Characteristics

| Symbol          | Parameter                                 | Typ | Max  | Units              |
|-----------------|-------------------------------------------|-----|------|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case      | --  | 0.94 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient * | --  | 40   | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient   | --  | 62.5 | $^\circ\text{C/W}$ |

\* When mounted on the minimum pad size recommended (PCB Mount)

**Electrical Characteristics**  $T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**Off Characteristics**

|                                |                                           |                                                                    |     |       |      |                     |
|--------------------------------|-------------------------------------------|--------------------------------------------------------------------|-----|-------|------|---------------------|
| $BV_{DSS}$                     | Drain-Source Breakdown Voltage            | $V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$               | -60 | --    | --   | V                   |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = -250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$ | --  | -0.06 | --   | V/ $^\circ\text{C}$ |
| $I_{DSS}$                      | Zero Gate Voltage Drain Current           | $V_{DS} = -60\text{ V}, V_{GS} = 0\text{ V}$                       | --  | --    | -1   | $\mu\text{A}$       |
|                                |                                           | $V_{DS} = -48\text{ V}, T_C = 150^\circ\text{C}$                   | --  | --    | -10  | $\mu\text{A}$       |
| $I_{GSSF}$                     | Gate-Body Leakage Current, Forward        | $V_{GS} = -25\text{ V}, V_{DS} = 0\text{ V}$                       | --  | --    | -100 | nA                  |
| $I_{GSSR}$                     | Gate-Body Leakage Current, Reverse        | $V_{GS} = 25\text{ V}, V_{DS} = 0\text{ V}$                        | --  | --    | 100  | nA                  |

**On Characteristics**

|              |                                   |                                                        |      |       |       |          |
|--------------|-----------------------------------|--------------------------------------------------------|------|-------|-------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$       | -2.0 | --    | -4.0  | V        |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = -10\text{ V}, I_D = -23.5\text{ A}$          | --   | 0.021 | 0.026 | $\Omega$ |
| $g_{FS}$     | Forward Transconductance          | $V_{DS} = -30\text{ V}, I_D = -23.5\text{ A}$ (Note 4) | --   | 21    | --    | S        |

**Dynamic Characteristics**

|           |                              |                                                                       |    |      |      |    |
|-----------|------------------------------|-----------------------------------------------------------------------|----|------|------|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = -25\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ | -- | 2800 | 3600 | pF |
| $C_{oss}$ | Output Capacitance           |                                                                       | -- | 1300 | 1700 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |                                                                       | -- | 320  | 420  | pF |

**Switching Characteristics**

|              |                     |                                                                                               |    |     |     |    |
|--------------|---------------------|-----------------------------------------------------------------------------------------------|----|-----|-----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = -30\text{ V}, I_D = -23.5\text{ A},$<br>$R_G = 25\text{ }\Omega$<br><br>(Note 4, 5) | -- | 50  | 110 | ns |
| $t_r$        | Turn-On Rise Time   |                                                                                               | -- | 450 | 910 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |                                                                                               | -- | 100 | 210 | ns |
| $t_f$        | Turn-Off Fall Time  |                                                                                               | -- | 195 | 400 | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = -48\text{ V}, I_D = -47\text{ A},$<br>$V_{GS} = -10\text{ V}$<br><br>(Note 4, 5)    | -- | 84  | 110 | nC |
| $Q_{gs}$     | Gate-Source Charge  |                                                                                               | -- | 18  | --  | nC |
| $Q_{gd}$     | Gate-Drain Charge   |                                                                                               | -- | 44  | --  | nC |

**Drain-Source Diode Characteristics and Maximum Ratings**

|                 |                                                       |                                                |    |      |      |    |
|-----------------|-------------------------------------------------------|------------------------------------------------|----|------|------|----|
| I <sub>S</sub>  | Maximum Continuous Drain-Source Diode Forward Current |                                                | -- | --   | -47  | A  |
| I <sub>SM</sub> | Maximum Pulsed Drain-Source Diode Forward Current     |                                                | -- | --   | -188 | A  |
| V <sub>SD</sub> | Drain-Source Diode Forward Voltage                    | V <sub>GS</sub> = 0 V, I <sub>S</sub> = -47 A  | -- | --   | -4.0 | V  |
| t <sub>rr</sub> | Reverse Recovery Time                                 | V <sub>GS</sub> = 0 V, I <sub>S</sub> = -47 A, | -- | 130  | --   | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge                               | dI <sub>F</sub> / dt = 100 A/μs (Note 4)       | -- | 0.55 | --   | μC |

**Notes:**

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L = 0.43\text{ mH}$ ,  $I_{AS} = -47\text{ A}$ ,  $V_{DD} = -25\text{ V}$ ,  $R_G = 25\text{ }\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq -47\text{ A}$ ,  $di/dt \leq 300\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature

## Typical Characteristics

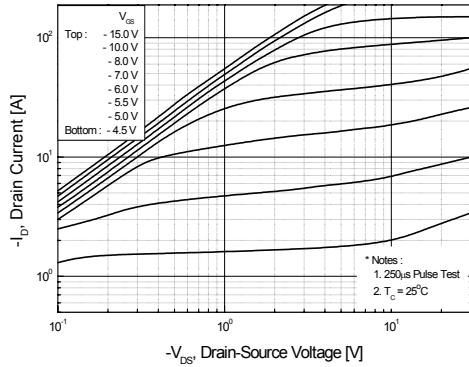


Figure 1. On-Region Characteristics

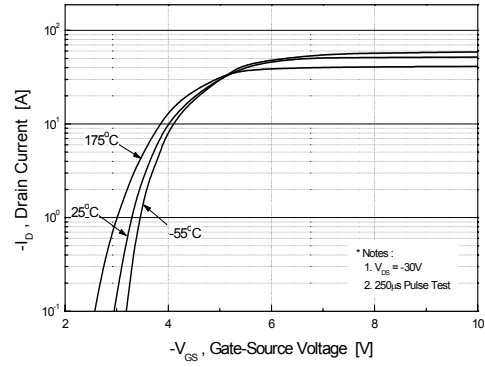


Figure 2. Transfer Characteristics

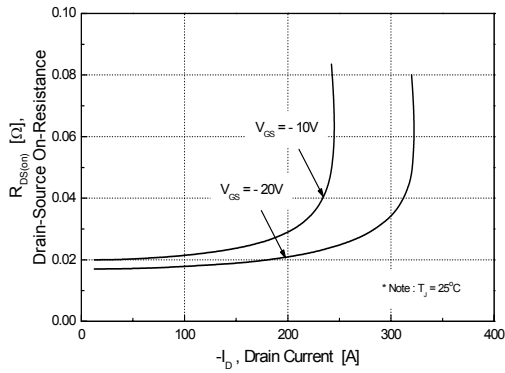


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

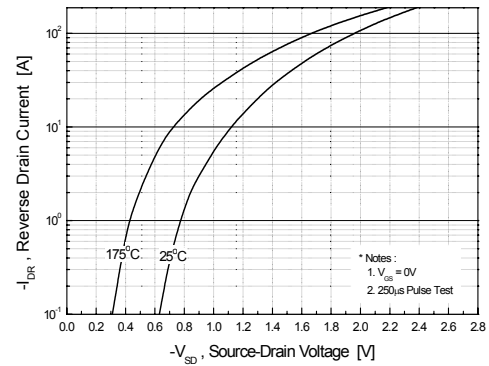


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

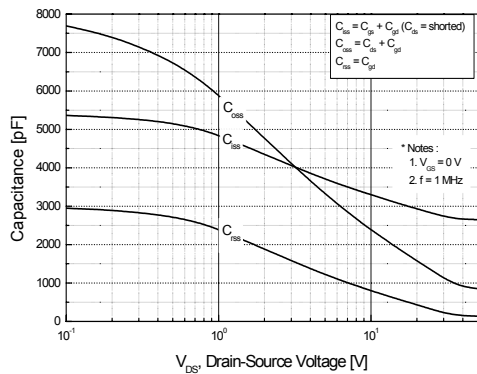


Figure 5. Capacitance Characteristics

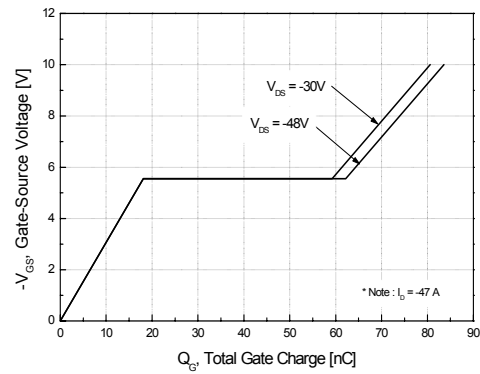
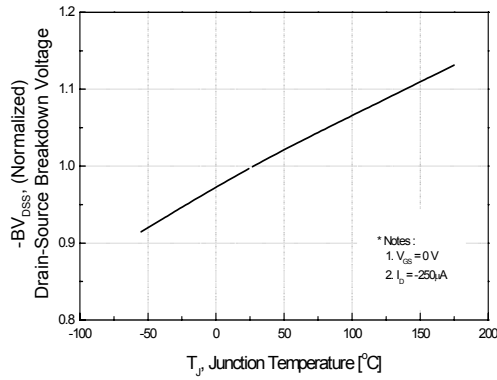
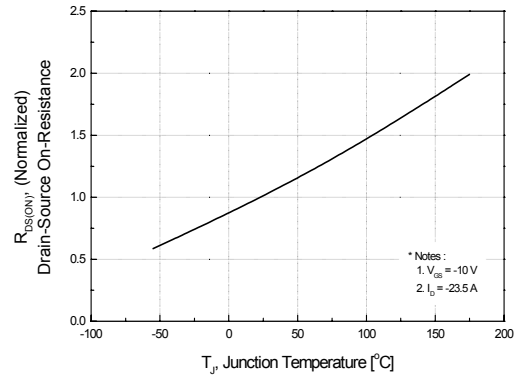


Figure 6. Gate Charge Characteristics

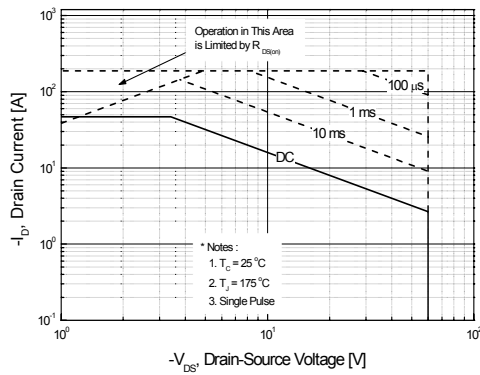
## Typical Characteristics (Continued)



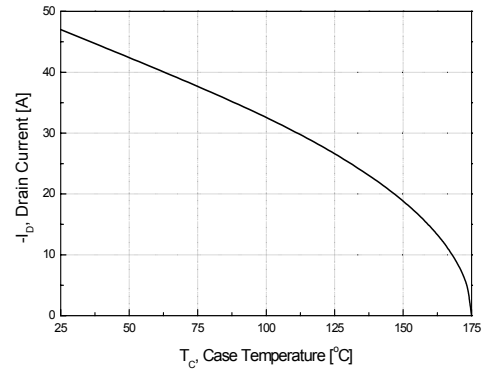
**Figure 7. Breakdown Voltage Variation vs. Temperature**



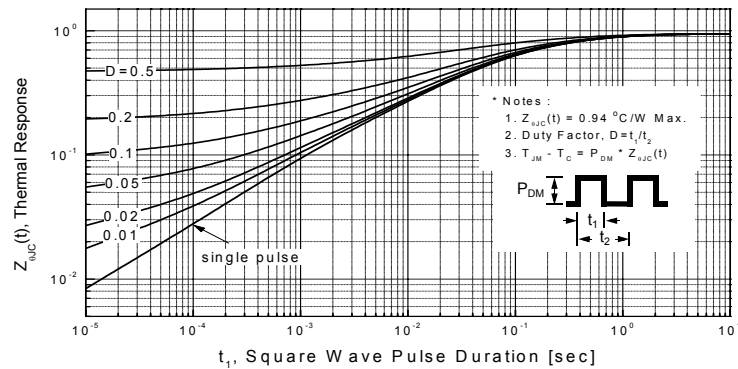
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**

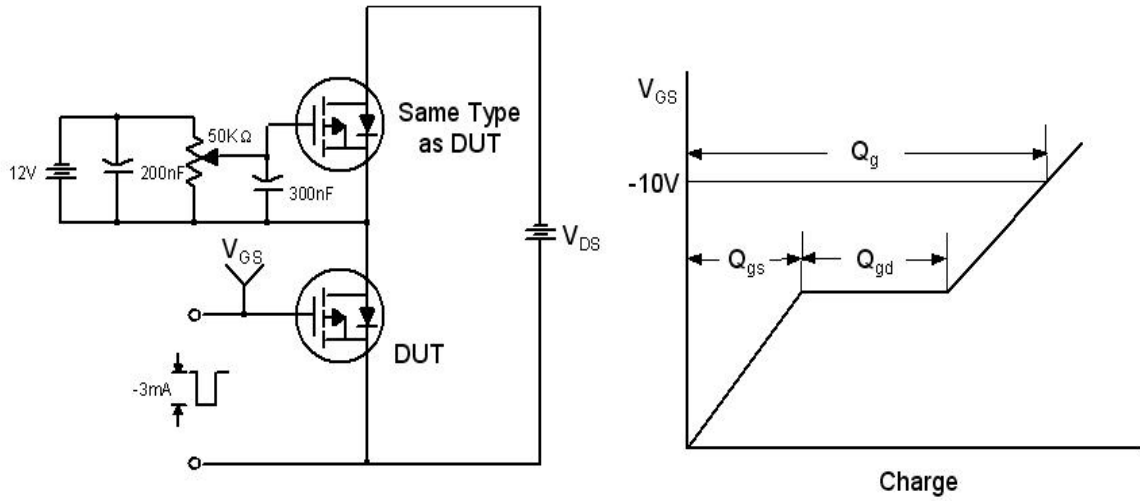


**Figure 10. Maximum Drain Current vs. Case Temperature**

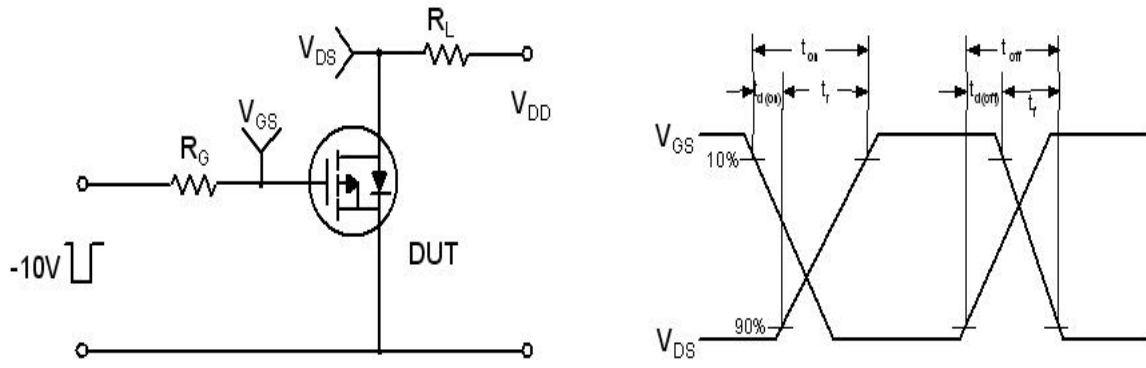


**Figure 11. Transient Thermal Response Curve**

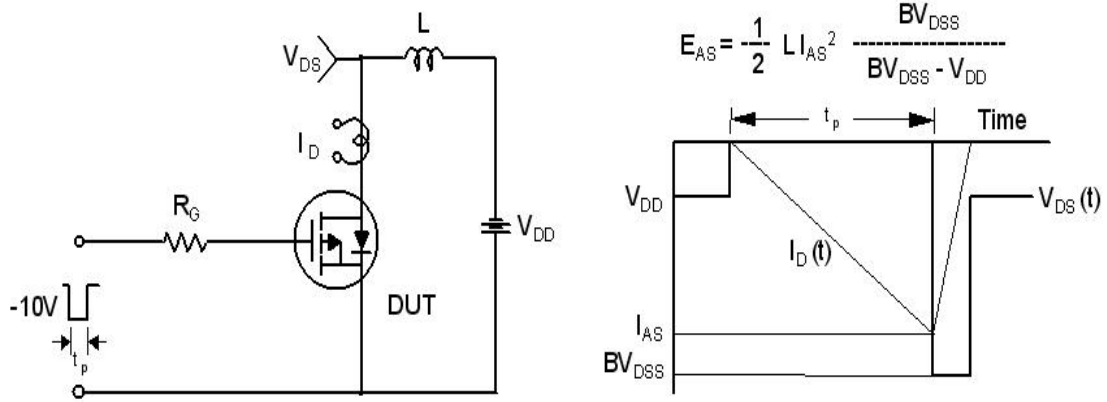
Gate Charge Test Circuit & Waveform



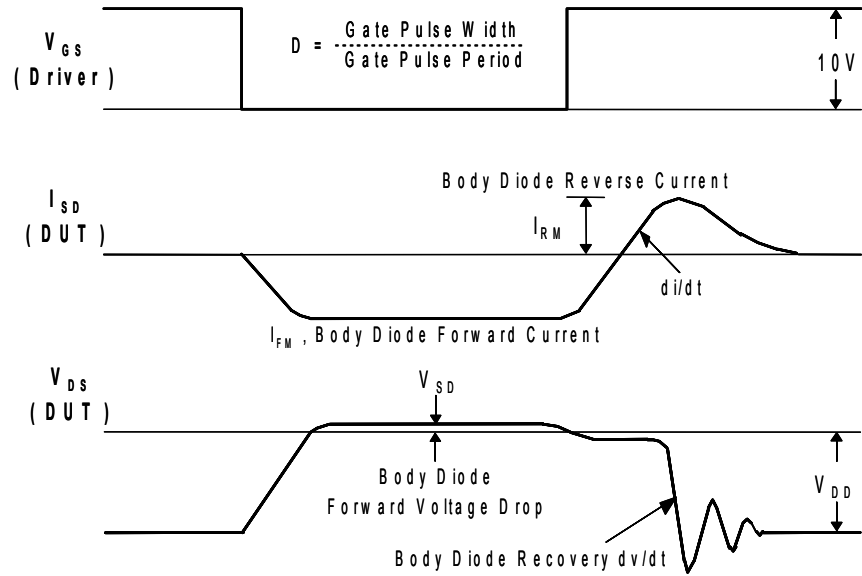
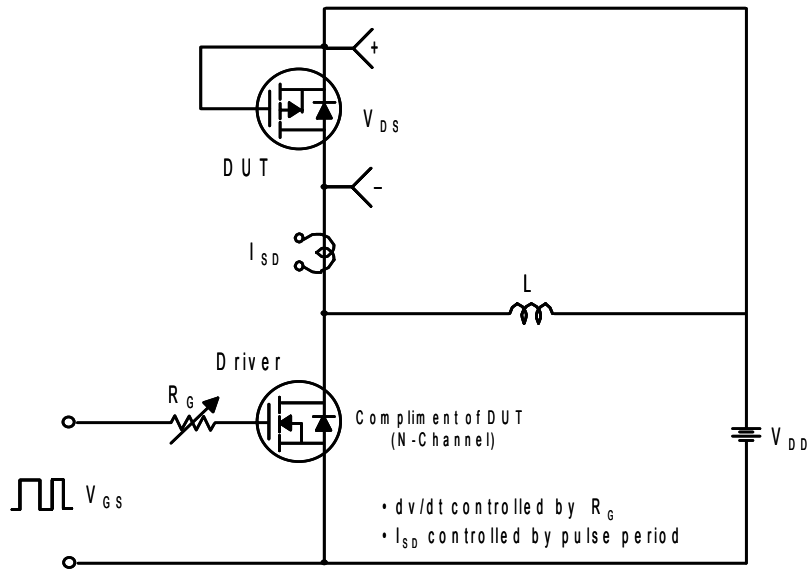
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



# Peak Diode Recovery dv/dt Test Circuit & Waveforms



**FQB47P06/FQ147P06 60V P-Channel MOSFET**

Technical drawing of a 1.5A connector showing three views: front, side, and top views with dimensions in millimeters.

**Front View Dimensions:**

- Overall width:  $9.90 \pm 0.20$
- Top flange height:  $1.40 \pm 0.20$
- Top flange thickness:  $1.20 \pm 0.20$
- Main body height:  $9.20 \pm 0.20$
- Total height:  $15.30 \pm 0.30$
- Bottom flange height:  $4.90 \pm 0.20$
- Pin spacing (center-to-center):  $2.54$  TYP
- Pin width:  $1.27 \pm 0.10$
- Pin thickness:  $0.80 \pm 0.10$

**Side View Dimensions:**

- Overall width:  $4.50 \pm 0.20$
- Top flange thickness:  $1.30^{+0.10}_{-0.05}$
- Main body height:  $2.00 \pm 0.10$
- Pin height:  $0.10 \pm 0.15$
- Pin width:  $2.40 \pm 0.20$
- Pin thickness:  $2.54 \pm 0.30$
- Pin spacing (center-to-center):  $2.54$  TYP
- Pin width:  $0.50^{+0.10}_{-0.05}$
- Pin thickness:  $0.80 \pm 0.10$

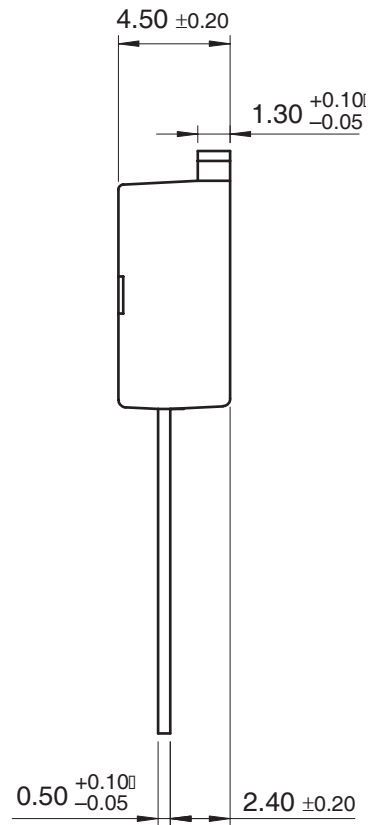
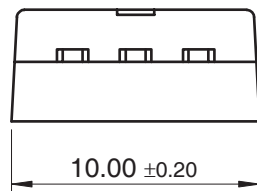
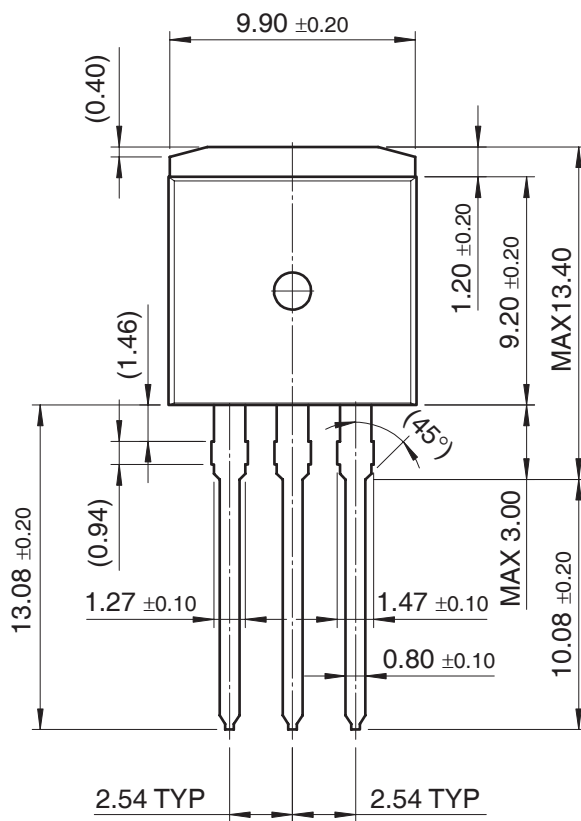
**Top View Dimensions:**

- Overall width:  $10.00 \pm 0.20$
- Inner width:  $8.00$
- Inner width (excluding pins):  $4.40$
- Pin width:  $1.27 \pm 0.10$
- Pin thickness:  $0.80 \pm 0.10$

FQB47P06/FQI47P06 60V P-Channel MOSFET

Package Dimensions (Continued)

I<sup>2</sup>PAK





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